Product data sheet

1. General description

High voltage, high speed, planar passivated NPN power switching transistor with integrated anti-parallel E-C diode in a SOT78 (TO-220AB) plastic package.

2. Features and benefits

- · Low thermal resistance
- Fast switching
- · High voltage capability
- Integrated anti-parallel E-C diode

3. Applications

- Integrated fluorescent lamp ballasts e.g. high power cluster lamps
- Low Voltage Tungsten Halogen transformers
- · Remote fluorescent lamp ballasts
- · Self Oscillating Power Supplies

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Values				Unit				
Absolute	Absolute maximum rating										
V _{CESM}	collector-emitter peak voltage	V _{BE} = 0 V	700			V					
I _c	collector current	DC; Fig. 1; Fig. 2; Fig. 4	4			Α					
P _{tot}	total power dissipation	T _{mb} ≤ 25 °C; <u>Fig. 3</u>	75			W					
Symbol	Parameter	Conditions	Min Typ Ma:		Max	Unit					
Static ch	Static characteristics										
h _{FE}	DC current gain	I _C = 1.0 A; V _{CE} = 5 V; <u>Fig. 10</u>	12 20 40								
		I _C = 2.0 A; V _{CE} = 5 V; <u>Fig. 10</u>		10	17	28					

NPN power transistor with integrated diode

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	В	base	mb	С
2	С	collector		<u> </u>
3	Е	emitter		В—Қ
mb	С	mounting base; connected to collector		E sym131

6. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PHD13005	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

NPN power transistor with integrated diode

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V _{CESM}	collector-emitter peak voltage	V _{BE} = 0 V	700	V
V _{CBO}	collector-base voltage	I _E = 0 A	700	V
V _{CEO}	collector-emitter voltage	I _B = 0 A	400	V
Ic	collector current	DC; Fig. 1; Fig. 2; Fig. 4	4	А
I _{CM}	peak collector current	Fig. 1; Fig. 2; Fig. 4	8	А
I _B	base current	DC	2	Α
I _{BM}	peak base current		4	А
P _{tot}	total power dissipation	T _{mb} ≤ 25 °C; <u>Fig. 3</u>	75	W
T _{stg}	storage temperature		-65 to 150	°C
T _j	junction temperature		150	°C

NPN power transistor with integrated diode

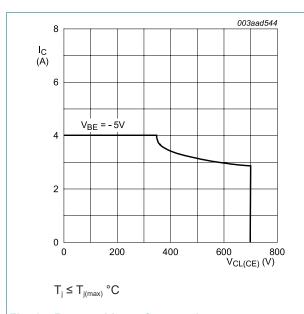
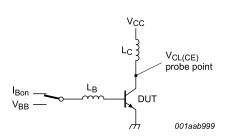
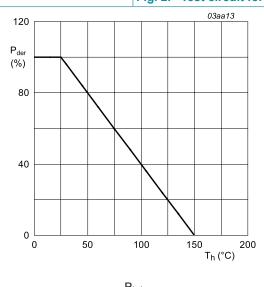


Fig. 1. Reverse bias safe operating area



$$\begin{split} &V_{\text{CL(CE)}} \leq 1000 \text{ V; } V_{\text{CC}} = 150 \text{ V; } V_{\text{BB}} = \text{--} 5 \text{ V;} \\ &L_{\text{B}} = 1 \text{ } \mu\text{H; } L_{\text{C}} = 200 \text{ } \mu\text{H.} \end{split}$$

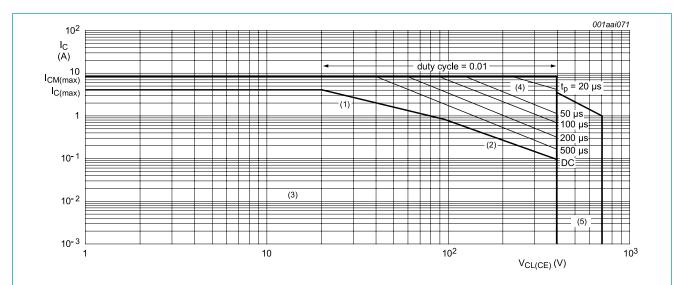
Fig. 2. Test circuit for reverse bias safe operating area



 $P_{der}(\%) = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$

Fig. 3. Normalized total power dissipation as a function of heatsink temperature

NPN power transistor with integrated diode



T_h ≤ 25 °C

Mounted with heatsink compound and (30 ± 5) N force on the center of the envelope

- (1) P_{tot} maximum and P_{tot} peak maximum lines
- (2) Second breakdown limits
- (3) Region of permissible DC operation
- (4) Extension of operating region for repetitive pulse operation
- (5) Extension of operating region during turn-on in single transistor converters provided that

 $R_{BE} \le 100 \Omega$ and $t_p \le 0.6 \mu s$.

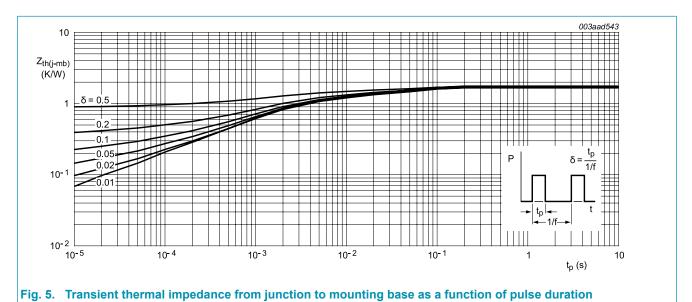
Fig. 4. Forward bias safe operating area

NPN power transistor with integrated diode

8. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	-	1.67	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air	-	60	-	K/W



NPN power transistor with integrated diode

9. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
I _{CES} collector-emitter cut-off current		$V_{BE} = 0 \text{ V}; V_{CE} = 700 \text{ V}; T_j = 100 \text{ °C}; [1]$	-	-	5	mA
	current	V _{BE} = 0 V; V _{CE} = 700 V; [1]	-	-	1	mA
I _{CBO}	collector-base cut-off current	V _{CB} = 700 V; I _E = 0 A; [1]	-	-	1	mA
I _{CEO}	collector-emitter cut-off current	V _{CE} = 400 V; I _B = 0 A; [1]	-	-	0.1	mA
I _{EBO}	emitter-base cut-off current	V _{EB} = 9 V; I _C = 0 A	-	-	10	mA
V_{CEOsus}	collector-emitter sustaining voltage	$I_B = 0 \text{ A}$; $I_C = 10 \text{ mA}$; $L_C = 25 \text{ mH}$; Fig. 6; Fig. 15	400	-	-	V
V _{CEsat}	collector-emitter	I _C = 1.0 A; I _B = 0.2 A; <u>Fig. 7</u> ; <u>Fig. 8</u>	-	0.1	0.5	V
saturation voltage	saturation voltage	I _C = 2.0 A; I _B = 0.5 A; <u>Fig. 7</u> ; <u>Fig. 8</u>	-	0.2	0.6	V
	I _C = 4.0 A; I _B = 1.0 A; <u>Fig. 7</u> ; <u>Fig. 8</u>	-	0.3	1	V	
V _{BEsat}	base-emitter saturation	I _C = 2.0 A; I _B = 0.5 A; <u>Fig. 9</u>	-	0.92	1.6	V
	voltage	I _C = 1.0 A; I _B = 0.2 A; <u>Fig. 9</u>	-	0.85	1.2	V
V _F	forward voltage	I _F = 2.0 A	-	1.04	1.5	V
h _{FE} DC current gain	DC current gain	I _C = 1.0 A; V _{CE} = 5 V; <u>Fig. 10</u>	12	20	40	
		I _C = 2.0 A; V _{CE} = 5 V; <u>Fig. 10</u>	10	17	28	
Dynamic	characteristics					
t _s	storage time	I_C = 2.0 A; I_{Bon} = 0.4 A; V_{BB} = -5 V; L_B = 1 μ H; inductive load; <u>Fig. 11</u> ; <u>Fig. 12</u>	-	1.2	2	μs
		I_C = 2.0 A; I_{Bon} = 0.4 A; I_{Boff} = -0.4 A; R_L = 75 Ω ; resistive load; <u>Fig. 13</u> ; <u>Fig. 14</u>	-	2.7	4	μs
		$I_{C} = 2.0 \text{ A}; I_{Bon} = 0.4 \text{ A}; V_{BB} = -5 \text{ V};$ $L_{B} = 1 \mu\text{H}; T_{j} = 100 ^{\circ}\text{C}; \text{ inductive load};$ <u>Fig. 11; Fig. 12</u>	-	1.4	4	μs
t _r fall t	fall time	I_C = 2.0 A; I_{Bon} = 0.4 A; I_{Boff} = -0.4 A; R_L = 75 Ω ; resistive load; <u>Fig. 13</u> ; <u>Fig. 14</u>	-	0.3	0.9	μs
		I_{C} = 2.0 A; I_{Bon} = 0.4 A; V_{BB} = -5 V; L_{B} = 1 μ H; T_{j} = 100 °C; inductive load; <u>Fig. 11</u> ; <u>Fig. 12</u>	-	0.16	0.9	μs
		I_C = 2.0 A; I_{Bon} = 0.4 A; V_{BB} = -5 V; L_B = 1 μ H; inductive load; Fig. 11; Fig. 12	-	0.1	0.5	μs

^[1] Measured with half-sine wave voltage (curve tracer).

NPN power transistor with integrated diode

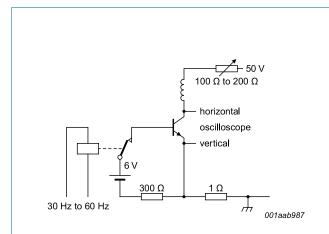
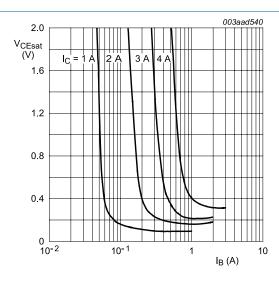


Fig. 6. Test circuit for collector-emitter sustaining voltage



 $T_i = 25 \,^{\circ}C$

Fig. 7. Collector-emitter saturation voltage; typical values

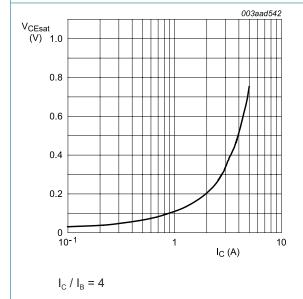


Fig. 8. Collector-emitter saturation voltage as a function of collector current; typical values

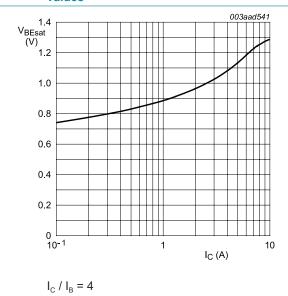


Fig. 9. Base-emitter saturation voltage; typical values

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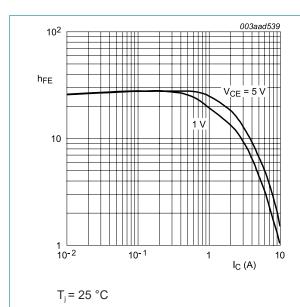
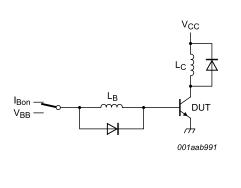


Fig. 10. DC current gain as a function of collector current; typical values



$$V_{CC} = 300 \text{ V}; V_{BB} = -5 \text{ V}; L_{C} = 200 \mu\text{H}; L_{B} = 1 \mu\text{H}.$$

Fig. 11. Test circuit for inductive load switching

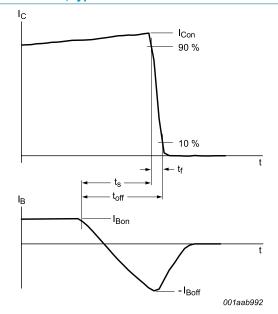
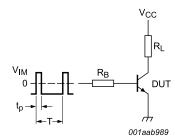


Fig. 12. Switching times waveforms for inductive load



$$V_{IM}$$
 = -6 V to +8 V; V_{CC} = 250 V; t_p = 20 μs ; δ = t_p/T = 0.01. R_B and R_L calculated from I_{Con} and I_{Bon} requirements

Fig. 13. Test circuit for resistive load switching

NPN power transistor with integrated diode

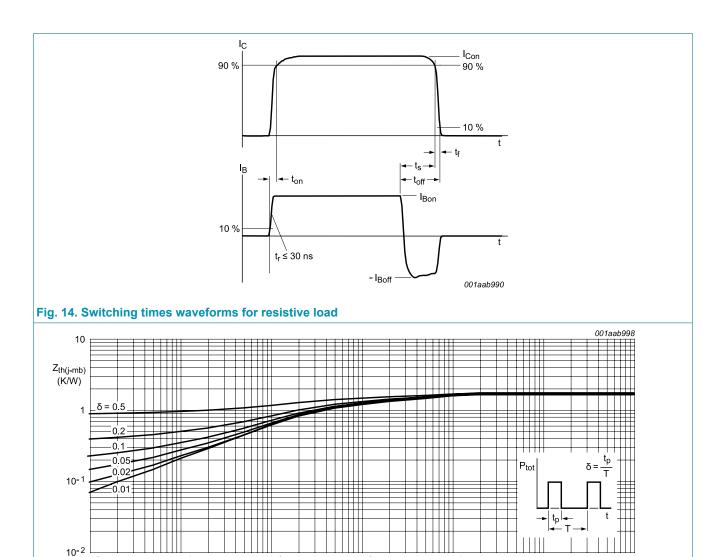


Fig. 15. Transient thermal impedance from junction to mounting base as a function of pulse width

10-2

10⁻¹

10⁻³

10

t_p (s)

10-5

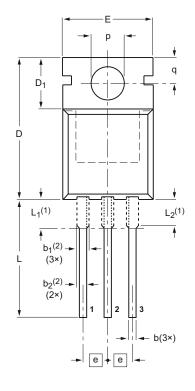
10-4

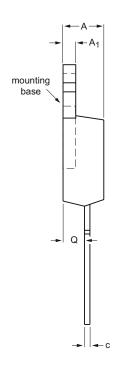
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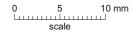
10. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78







DIMENSIONS (mm are the original dimensions)

UNIT	Α	A ₁	b	b ₁ ⁽²⁾	b ₂ ⁽²⁾	С	D	D ₁	E	е	L	L ₁ ⁽¹⁾	L ₂ ⁽¹⁾ max.	р	q	Q
mm	4.7 4.1	1.40 1.25	0.9 0.6	1.6 1.0	1.3 1.0	0.7 0.4	16.0 15.2	6.6 5.9	10.3 9.7	2.54	15.0 12.8	3.30 2.79	3.0	3.8 3.5	3.0 2.7	2.6 2.2

Notes

- Lead shoulder designs may vary.
- 2. Dimension includes excess dambar.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT78		3-lead TO-220AB	SC-46		08-04-23 08-06-13

NPN power transistor with integrated diode

11. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
PHD13005 v.3	20180330	Product data sheet	-	PHD13005 v.2				
Modifications:	Change from NXP version to WeEn version							
PHD13005 v.2	20100729	Product data sheet	-	PHD13005 v.1				
Modifications:	Various changes to content.							
PHD13005 v.1	20100520	Product data sheet	-	-				

NPN power transistor with integrated diode

12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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NPN power transistor with integrated diode

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NPN power transistor with integrated diode

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